Search No	IS

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/773,917	CHAN ET AL.	
Examiner	Art Unit	
Mitchell R. Slavitt	2627	

SEARCHED				
Class	Subclass	Date	Examiner	
	(Y)			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	search - see tout	6/9/2006	MS

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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